Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

General Description

The MAX20067/MAX20067B are complete TFT bias solutions for automotive applications. They include a current-mode boost converter and two push-pull charge-pump drivers.

The ICs also include a gate-shading push-pull level shifter that can be used to improve display uniformity (when needed), and a DAC and VCOM buffer. All blocks on the ICs can be used in stand-alone mode or through the I²C interface.

Comprehensive control functions are included using the built-in I²C interface, as well as diagnostics and monitoring.

The ICs are intended to operate with 2.7V to 5.5V supplies.

The MAX20067/MAX20067B are available in a 32-pin TQFN package and operate in the -40°C to +105°C temperature range.

Applications

- Infotainment Displays
- Central Information Displays
- Instrument Clusters

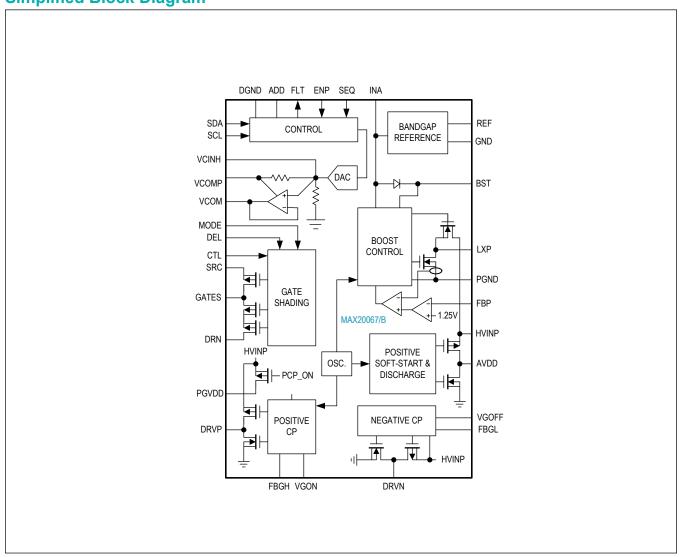
Benefits and Features

- Versatile TFT Display Power Section
 - Integrated Synchronous Boost Converter with Output Voltages Up to 18V and High-power (MAX20067) or Lower-power (MAX20067B) Options
 - Integrated Charge-Pump Drivers for the VGON (+32V, max) and VGOFF (-24V, min) Outputs
- Low EMI Operation
 - Programmable Switching Frequencies of 440kHz or 2.2MHz
 - · Programmable Spread Spectrum
- Full Sequencing Flexibility Through I²C, Along with Preset Sequences Using SEQ Pin
- Extended Diagnostics Using I²C Interface
 - Undervoltage/Overvoltage on HVINP, VGON, and VGOFF
 - Overcurrent on AVDD
 - · Temperature Warning
- Built-In Gate-Shading Circuit Controlled by CTL Input
- 8-Bit DAC-Controlled VCOM Buffer
- Robust
 - -40°C to +105°C Operating Temperature Range
 - · Internal Temperature Shutdown
 - AEC-Q100 Qualified
- Compact 32-Pin (5mm x 5mm) TQFN Package

Ordering Information appears at end of datasheet.



Simplified Block Diagram



Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

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MAX20067/MAX20067B	Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I ² C Interface

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Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

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Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Absolute Maximum Ratings

INA, SDA, SCL, ENP, FLTB, CTL to GNI DEL, REF, FBP, FBGH, FBGL, SEQ, MO	
	0.3V to INA + 0.3V
LXP, BST to GND	0.3V to 26V
BST to LXP	0.3V to +6V
HVINP, VCOMP to GND	0.3V to +26V
VCINH, VCOM to GND	0.3V to V _{COMP} + 0.3V
VCINH to VCOM	<u>+</u> 1V
AVDD, PGVDD to HVINP	
VGON, SRC, DRN to GND	0.3V to +34V
DRN to GATES	34V to +34V
GATES to GND	0.3V to SRC + 0.3V
VGOFF to GND	26V to +0.3V

DRVP, DRVN to PGNDGND to PGND	
GND to DGND	-0.3V to +0.3V
LXP Continuous Current	2.4A
Continuous Power Dissipation (Multilayer	r Board) (T _A = +70°C)
	W to 2.758W
Package Thermal Resistance	1.7°C/W
ESDHB	2kV to +2kV
ESDMM	200V to +200V
Operating Temperature	40°C to 105°C
Junction Temperature	
Storage Temperature Range	65°C to +150°C
Lead Temperature Range	+300°C

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a 4-layer board. For detailed information on package thermal considerations see www.maximintegrated.com/thermal-tutorial.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Package Information

32-Pin TQFN

T3255+4C
21-0140
90-0012
47
1.7
29
1.7

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

Electrical Characteristics

 $(V_{INA} = 3.6V, Limits are 100\% tested at T_A = +25^{\circ}C$ and $T_A = +105^{\circ}C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked "GBD" are guaranteed by design and not production tested. <math>T_A = T_J = -40^{\circ}C$ to $+105^{\circ}C$, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$, unless otherwise noted)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
INA POWER INPUT						
INA Supply Voltage Range	V _{INA}		2.7		5.5	V
INA Undervoltage- Lockout Threshold, Rising	UVLO _R		2.45	2.55	2.65	V

Electrical Characteristics (continued)

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
INA Undervoltage- Lockout Threshold, Falling	UVLO _F			2.45		V
Supply Current	I _{INA}	ENP = 1 or ENP bit = 1, no switching		1.8	3	mA
Shutdown Current	I _{SD}	ENP = 0 and ENP bit = 0, total current INA + HVINP		7	15	μA
OSCILLATOR			•			•
Boost Converter Switching Frequency	f _{SW0}	SWFREQ bit = 0	1.98	2.2	2.42	MHz
Boost Converter Switching Frequency, Low Setting	fsw1	SWFREQ bit = 1	390	440	490	kHz
Frequency Dither		SSOFF bit = 1	-4		+4	%
REFERENCE			•			•
REF Output Voltage	V _{REF}		1.238	1.25	1.262	V
REF Load Regulation		I _{REF} from 0μA to 100μA		10	20	mV
REF Line Regulation		2.7V < V _{INA} < 5.5V, no load			5	mV
BOOST CONVERTER			<u>'</u>			
AVDD Output Voltage Range	V _{AVDD}		V _{INA} + 1		18	V
LVD Commont Limit		MAX20067B, 75% duty-cycle	0.75	1	1.25	
LXP Current Limit		MAX20067, 85% duty cycle	2.1	2.5	2.9	A
Low-Side Switch On- Resistance	R _{LXP}			0.2	0.4	Ω
LXP Leakage Current	I _{LXP}	V _{LXP} = 18V, T _A = +25°C			5	μA
Synchronous Rectifier On-Resistance	R _{SYNC}			0.25	0.5	Ω
Synchronous Rectifier Zero-Crossing Threshold	I _{SYNCZ}	2.2MHz		140		mA
Maximum Duty Cycle	DC _{MAX}		90	94	98	%
Current-Limit Ramp Time at Startup	t _{RAMP}			12.5		ms
FBP Regulation Voltage	V _{FPB}		1.225	1.25	1.275	V
FBP Load Regulation		1mA < I _{AVDD} < 200mA		-1		%
FBP Line Regulation		V _{INA} = 2.7V to 5.5V	-0.4		+0.4	%
FBP Undervoltage-Fault Threshold	V _{FBPUV}		75	80	85	%
FBP Overvoltage-Fault Threshold	V _{FBPOV}		110	115	120	%

Electrical Characteristics (continued)

 $(V_{INA} = 3.6V, Limits are 100\% tested at T_A = +25^{\circ}C and T_A = +105^{\circ}C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked "GBD" are guaranteed by design and not production tested. <math>T_A = T_J = -40^{\circ}C$ to +105°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$, unless otherwise noted)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
FBP Input Bias Current	I _{FBP}				200	nA
HVINP-AVDD Switch On-Resistance	R _{HA}			0.5	1	Ω
AVDD Discharge Resistance	R _{AVDD}		1	1.5	2	kΩ
HVINP-AVDD Switch	I _{LIMHA}	After soft-start	240			mA
Current Limit		During soft-start	120			
POSITIVE CHARGE-PUN	IP REGULATOR	R				
PGVDD Operating Voltage Range	V _{PGVDD}		6		18	V
VGON Output Voltage Range	V_{VGON}				32	V
DRVP Current Limit	I _{LIM_P}		40			mA
Positive Charge-Pump Switching Frequency				440		kHz
FBGH Regulation Voltage	V_{FBGH}		1.225	1.25	1.275	V
FBGH Undervoltage- Fault Threshold	V _{FBGHUV}		75	80	85	%
FBGH Overvoltage- Fault Threshold	V _{FBGHOV}		110	115	120	%
DRVP On-Resistance High	R _{ONH_DRVP}				60	Ω
DRVP On-Resistance Low	R _{ONL_DRVP}				30	Ω
HVINP-PGVDD Switch On-Resistance	R _{HP}			30	60	Ω
HVINP-PGVDD Current Limit			40			mA
VGON Discharge Resistance			8	12	16	kΩ
NEGATIVE CHARGE-PU	MP REGULATO	R				
VGOFF Output Voltage Range			-24		-4	V
DRVN Current Limit	I _{LIMN}		15			mA
Negative Charge-Pump Switching Frequency				440		kHz
FBGL Regulation Voltage	V _{FBGL}	V _{REF} - V _{FBGL}	0.98	1	1.02	V
FBGL Undervoltage- Fault Threshold	V _{FBGLUV}	Rising	400	450	500	mV

Electrical Characteristics (continued)

 $(V_{INA} = 3.6V, Limits are 100\% tested at T_A = +25^{\circ}C and T_A = +105^{\circ}C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked "GBD" are guaranteed by design and not production tested. <math>T_A = T_J = -40^{\circ}C$ to +105°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$, unless otherwise noted)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
FBGL Overvoltage-Fault Threshold	V _{FBGLOV}	Falling	20	50	100	mV
DRVN On-Resistance High	R _{ONH_DRVN}				60	Ω
DRVN On-Resistance Low					30	Ω
VGOFF Discharge Resistance			8	12	16	kΩ
GATE-SHADING CIRCUI	Т					
SRC Input Voltage Range	V _{SRC}				32	V
SRC-to-GATES Switch On-Resistance	R _{SRC_GATES}			10	20	Ω
DRN-to-GATES Switch On-Resistance	R _{DRN_GATES}			10	20	Ω
DEL Pullup Current			4	5	6	μA
DEL Enable Threshold				1.25		V
CTL-to-GATES Delay		C _{GATES} = 1nF		150		ns
MODE Switch On- Resistance				1250		Ω
MODE Voltage Threshold		MODE rising	2			V
MODE Pullup Current			80	100	120	μA
MODE Current-Source Stop Threshold				1.7		V
VCOM BUFFER						
VCOMP Voltage Range			5		18	V
VCOMP Quiescent Supply Current		I _{VCOMP} = 0mA, V _{COMP} = 12V		1.8		mA
VCINH Input Impedance				500		kΩ
VCINH/VCOMP Division Ratio				0.5		V/V
VCOM Output Current Limit			130			mA
VCOM Offset Voltage			-8		+8	mV
VCOM Output Voltage Range			1.5		V _{COMP} - 1.5V	V
VCOM DAC Step Size				19.5		mV
VCOM DAC Voltage Range				V _{COMP} / 2 <u>+</u> 2.5V		V

Electrical Characteristics (continued)

 $(V_{INA} = 3.6V, Limits are 100\% tested at T_A = +25^{\circ}C and T_A = +105^{\circ}C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked "GBD" are guaranteed by design and not production tested. <math>T_A = T_J = -40^{\circ}C$ to +105°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$, unless otherwise noted)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
VCOM Undervoltage- Detection Threshold		VCINH - VCOM, falling	-0.55	-0.35	-0.15	V
VCOM Overvoltage- Detection Threshold		VCINH - VCOM, rising	0.04	0.25	0.41	V
VCOM Fault Detection Filter Time		tfault[1:0] = 01		60		ms
VCOM Discharge Resistance			6	13	20	kΩ
TFT FAULT PROTECTION	N					
Fault Timeout		tfault[1:0] = 01		60		ms
Fault Retry Time				2.4		s
FLTB Output Frequency		Stand-alone mode only	0.88	1	1.12	kHz
FLTB Output Duty Cycle, VGON or VGOFF Fault				75		%
FLTB Output Duty Cycle, HVINP Fault				50		%
FLTB Output Duty Cycle, AVDD Fault				25		%
AVDD Undervoltage- Fault Threshold		Relative measurement between HVINP and AVDD	70	75	80	%
FBP Short-Circuit Fault Threshold			30	40	50	%
FBGH Short-Circuit Fault Threshold			30	40	50	%
FBGL Short-Circuit Fault Threshold			0.8	0.85	0.9	V
Short-Circuit and Overload Fault Delay				10		μs
THERMAL PROTECTION	l					
Thermal Shutdown	T _{SHDN}			165		°C
Thermal-Shutdown Hysteresis	T _{SHDN_HYS}			15		°C
LOGIC INPUT AND OUT	PUTS					
FLTB, DEL Low Output Voltage	V _{OL}	I _{SINK} = 5mA			0.4	V
FLTB, DEL, SDA Leakage Current	I _{ILEAK}		-1		+1	μА
SDA Output Voltage Low	V _{OLSDA}				0.8	V
ENP Pulldown Resistor Value	R _{ENPPD}		50	75		kΩ

Electrical Characteristics (continued)

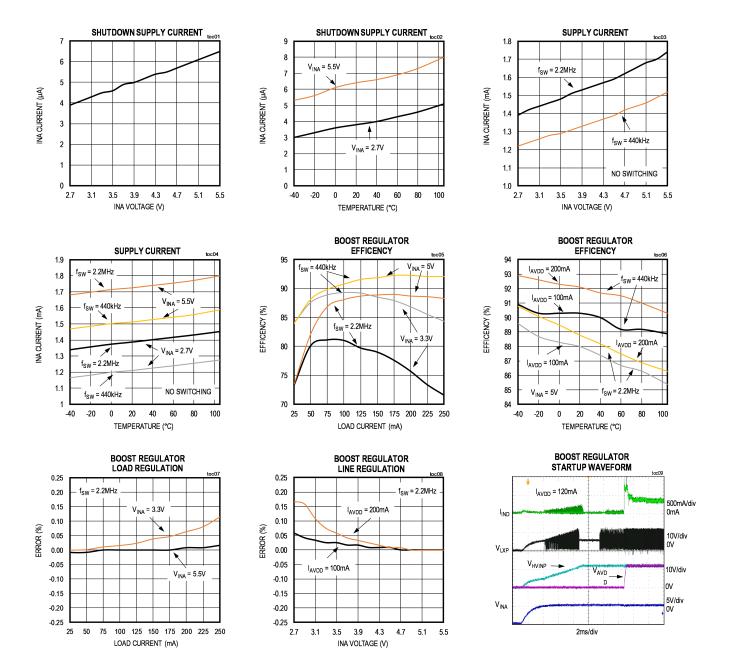
 $(V_{INA} = 3.6V, Limits are 100\% tested at T_A = +25^{\circ}C and T_A = +105^{\circ}C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked "GBD" are guaranteed by design and not production tested. <math>T_A = T_J = -40^{\circ}C$ to +105°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$, unless otherwise noted)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
ENP Glitch Filter Time	t _{ENP}			10		μs
ENP, CTL, SCL, SDA, ADD Input Voltage Low	V _{IL}				0.8	V
ENP, CTL, SCL, SDA, ADD Input Voltage High	V _{IH}		2			V
I2C INTERFACE						
Clock Frequency	f _{SCL}				400	kHz
Setup Time (Repeated) START	^t su:sta		260			ns
Hold Time (Repeated) START	t _{HD:STA}		260			ns
SCL Low Time	t _{LOW}		350			ns
SCL High Time	tHIGH		260			ns
Data Setup Time	tsu:dat		50			ns
Data Hold Time	t _{HD:DAT}		0			ns
Setup Time for STOP Condition	tsu:sto		260			ns
Spike Suppression				50		ns

Note 2: Note 1: Limits are 100% tested at T_A = +25°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization.

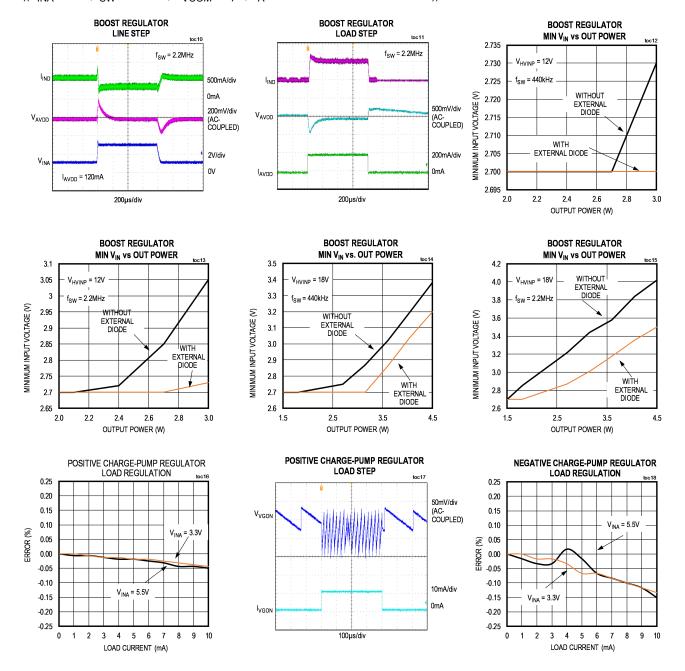
Typical Operating Characteristics

((V_{INA} = 3.3V, f_{SW} = 2.2MHz, C_{VCOM} = 1 μ F, T_A = +25 $^{\circ}$ C unless otherwise noted.))



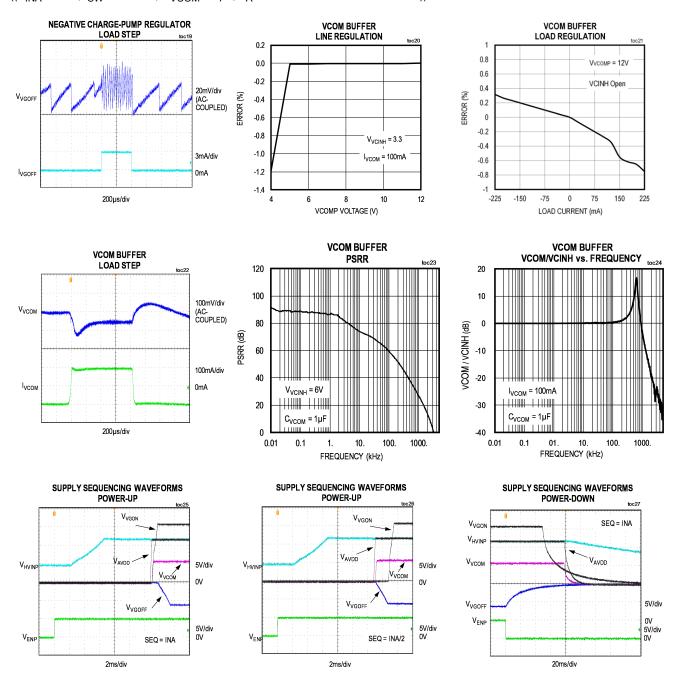
Typical Operating Characteristics (continued)

((V_{INA} = 3.3V, f_{SW} = 2.2MHz, C_{VCOM} = 1 μ F, T_A = +25 $^{\circ}$ C unless otherwise noted.))



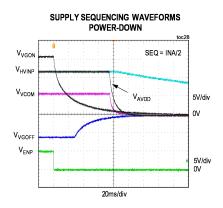
Typical Operating Characteristics (continued)

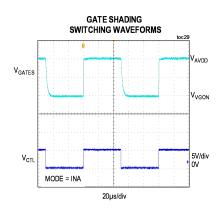
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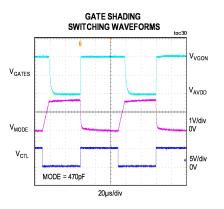


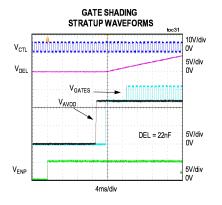
Typical Operating Characteristics (continued)

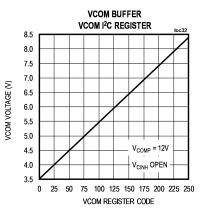
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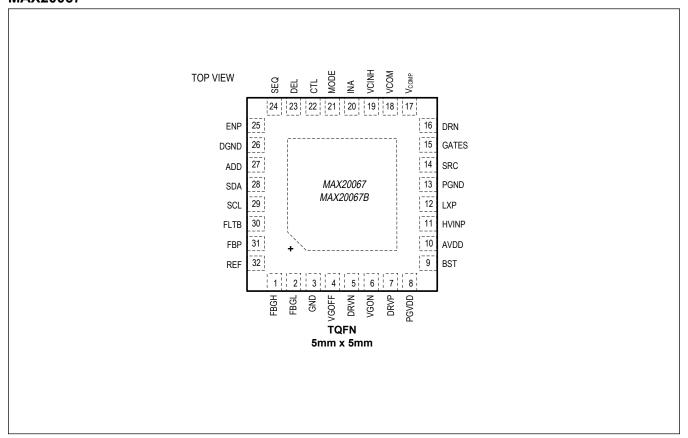






Pin Configuration

MAX20067



Pin Description

PIN	NAME	FUNCTION	REF SUPPLY
1	FBGH	Positive Charge-Pump Feedback Connection. FBGH is regulated to 1.25V. Connect a resistor-divider from VGON to GND with its midpoint connected to FBGH.	
2	FBGL	Negative Charge-Pump Feedback Connection. FBGL is regulated to 0.25V. Connect a resistor-divider from REF to VGOFF with its midpoint connected to FBGL.	
3	GND	Ground Connection	
4	VGOFF	Output of Negative Charge-Pump Block.	
5	DRVN	Negative Charge-Pump Push-Pull Drive Output	
6	VGON	Output of Positive Charge-Pump Block	
7	DRVP	Positive Charge-Pump Push-Pull Drive Output	
8	PGVDD	Supply voltage for positive charge-pump. PGVDD is connected to HVINP by means of an internal switch when the positive charge-pump is enabled. Bypass PGVDD with a ceramic capacitor of at least 1µF to GND.	

Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Pin Description (continued)

PIN	NAME	FUNCTION	REF SUPPLY
9	BST	Bootstrap Capacitor Connection for Synchronous Rectifier Driver. Connect a 0.1µF ceramic capacitor between BST and LXP.	HVINP
10	AVDD	Switched Output of Boost Converter. Connect a bypass capacitor of at least 4.7µF from AVDD to PGND.	
11	HVINP	Boost Output and Input to Positive and Negative Charge Pumps. Bypass HVINP with the boost-converter output capacitor placed close to the pin.	
12	LXP	Switching Node of Boost Converter. Connect the boost inductor between LXP and INA.	
13	PGND	Ground Connection for Boost Switching Device and VCOM Buffer. Connect to GND using a low-impedance trace.	
14	SRC	Source of Internal High-Side Switch in Gate-Shading Circuit. SRC is usually connected to VGON. Bypass SRC with a 0.1µF capacitor placed close to the pin.	
15	GATES	Switched Output of Gate-Shading Circuit	
16	DRN	Lower Input of Gate-Shading Circuit. Connect to an external source or GND through a discharge resistor.	
17	VCOMP	Supply Voltage for VCOM Buffer. Normally connected to AVDD. Bypass V _{COMP} with a 0.1µF ceramic capacitor placed close to the pin.	
18	VCOM	Output of VCOM Amplifier. Bypass VCOM to GND with a 1µF ceramic capacitor.	
19	VCINH	Noninverting Input of VCOM Amplifier. In stand-alone mode, drive VCINH to set the VCOM output voltage. VCINH is prebiased to 50% of V_{COMP} with an internal resistor-divider comprising two 1M Ω resistors.	
20	INA	Supply Connection for Display Bias Circuitry. Bypass INA with a local 0.1µF capacitor.	
21	MODE	Mode Configuration Pin for Gate-Shading Level Shifter. MODE is used to adjust the timing of the gate-shading output. MODE is high impedance when connected to INA, and internally pulled down during UVLO or in shutdown.	
22	CTL	Control Input for Gate-Shading Circuit. When CTL is high, the switch between GATES and SRC is on and the switch between GATES and DRN is off. When CTL is low, the switch between GATES and DRN is on and the switch between GATES and SRC is off. CTL is inhibited by V _{CC} UVLO and when DEL is less than 1.25V.	
23	DEL	Gate-Shading Circuit Delay Input. Connect a capacitor from DEL to GND to set the turn-on delay.	
24	SEQ	Logic-Level Sequencing Input Pin. The voltage level on SEQ determines whether the IC is serially controlled, or one of the predetermined sequences is used. Connect SEQ to INA or a resistive divider between INA and GND to set one of the preset stand-alone sequences (see Table 3). For serial control, connect SEQ to GND.	
25	ENP	Active-High Enable Input for Boost Converter. ENP also enables the VGON and VGOFF regulators in the set sequence. ENP has an internal pulldown resistor. When serial control is used, connect ENP low.	
26	DGND	Digital Ground. Connect directly to the exposed pad of the package.	
27	ADD	I ² C Address-Selection Pin. Connect to GND for a base address of 0x20, or to INA for a base address of 0x28.	
28	SDA	Bidirectional I ² C Data Pin	

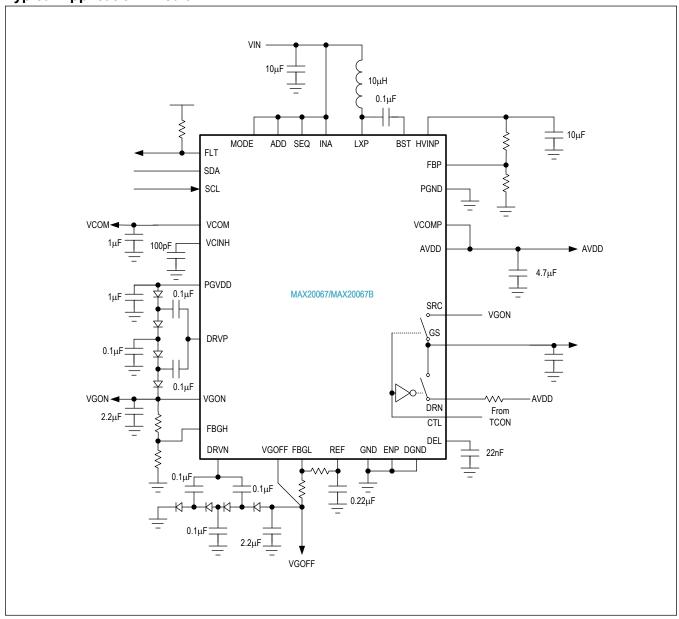
Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Pin Description (continued)

PIN	NAME	FUNCTION	REF SUPPLY
29	SCL	Serial-Clock Input	
30	FLTB	Open-Drain, Active-Low Fault Output. Connect a pullup resistor from FLTB to a logic supply ≤ 5V. In stand-alone mode, the duty cycle of the FLTB pin indicates an error condition, if present (see Table 4). When the serial interface is used, FLTB is either a 0 (indicating data to be read from the internal registers) or a 1. It does not output a PWM signal.	
31	FBP	Boost Feedback Connection. FBP is regulated to 1.25V. Connect a resistor-divider from HVINP to GND with its midpoint connected to FBP.	
32	REF	Internal 1.25V Reference Output. Connect a 0.22µF capacitor from REF to GND.	
-	EP	Exposed Pad. Connect EP to GND.	

Functional Diagrams

Typical Application Circuit



Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Detailed Description

The MAX20067/MAX20067B are highly integrated power-supply ICs for automotive TFT-LCD applications. The ICs integrate one boost converter, two gate-driver supplies, a high-voltage "gate-shading" level shifter, and a high-current VCOM buffer.

The main power-supply section, comprising the boost converter and gate-driver supplies, operates from a 2.7V to 5.5V supply. The boost converter operates at 440kHz or 2.2MHz and has built-in spread spectrum that can be disabled using the serial interface for reducing EMI.

The boost converter provides an output voltage adjustable up to 18V, with up to 200mA output current and has two internal MOSFET switching elements.

The ICs provide gate-driver supplies using positive and negative charge-pump regulators, with a current capability of 10mA for the positive charge pump (using a doubler charge pump) and 3mA for the negative charge pump (assuming a 2-stage charge pump). Output voltage is adjustable with a +32V (max) output on the positive charge pump and -24V on the negative charge pump.

The startup and shutdown sequences for all power domains, controlled using one of the preset modes, are selected using the SEQ pin. Sequencing can also be controlled through the serial interface when the SEQ pin is grounded.

TFT Power Section

Source-Driver Power Supplies

The source-driver power supply consists of a boost converter that generates +18V (max) and can deliver up to +200mA (+100mA for MAX20067B). The source-driver power supply's regulation voltage (HVINP) is set by a resistor-divider on FBP. The source driver uses constant-frequency peak-current-mode control, with internal fixed-slope compensation. Internal compensation stabilizes the control loop. At low output power, the converter enters skip mode.

The TFT boost converter has an internal error amplifier with a g_m of 13 μ S that has FBP and REF = 1.25V as inputs. There is an internal compensation network at the output of the error amplifier as follows:

$$C_C = 140 pF, R_C = 500 k\Omega$$

For the current loop, there is internal current sensing using a transresistance of R_T = 0.21V/A. The current-sense voltage (V_{CS} = I_inductor x R_T) is added to the slope compensation. The slope-compensation signal has a slope of 1250mV per microsecond. The resulting V_{SUM} = V_{CS} + V_{SLOPE} is compared to V_{COMP} (output of the error amplifier) at the input of the PWM comparator to regulate the LXP duty cycle.

Gate-Driver Power Supplies

The positive gate-driver charge pump (VGON) generates +32V (max) and the negative gate-driver charge pump (VGOFF) generates -24V (min). The gate-driver supplies have a current capability of 10mA for the positive charge pump (using a doubler charge pump) and 3mA for the negative charge pump (assuming a 2-stage charge pump). The VGON and VGOFF regulation voltages are both set using the external resistor networks, as shown in the *Typical Application Circuit*. Both charge-pump regulators use a 440kHz switching frequency. The charge pumps regulate the output voltages by controlling the current that flows into the flying capacitors.

Operation of the Positive Charge Pump

The positive charge-pump regulator is typically used to generate the positive supply rail for the TFT-LCD gate-driver ICs.

The output voltage is set with an external resistive voltage-divider from its output to GND, with the midpoint connected to FBGH. The number of charge-pump stages and the setting of the feedback-divider determine the output voltage of the positive charge-pump regulator. The charge pump push-pull output consists of a high-side p-channel MOSFET (P1) and a low-side n-channel MOSFET (N1) to control the power transfer.

The positive charge pump uses a simple skipping control scheme. The feedback signal (FBGH) is compared with a 1.25V internal reference. The result of this comparison is sampled on every clock cycle. If the feedback signal is below 1.25V,

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a DRVP cycle is initiated. In the first half period, the rising edge of the clock turns on N1 and turns off P1, allowing the flying capacitors to charge, while during the second half period, the falling edge of the clock turns off N1 allowing charge transfer to the output. During both phases, N1 and P1 act as current-limited switches with a current limit of at least 40mA.

Alternatively, if the feedback signal is above 1.25V at the clock rising edge, the regulator ignores the clock period and N1 and P1 remain off.

The charge-pump regulator also includes a discharge switch from VGON to ground, turned off to discharge the output capacitors during the sequential turn-off of the output voltages, as programmed by the SEQ pin or through I²C. The PGVDD node is internally connected through a switch to the HVINP voltage. See Table 3 for stand-alone sequencing options.

Operation of the Negative Charge Pump

The negative charge-pump regulator is typically used to generate the negative supply rail for the TFT-LCD gate-driver ICs. The output voltage is set with an external resistive voltage-divider from its output to REF, with the midpoint connected to FBGL. The number of charge-pump stages and the setting of the feedback-divider determine the output of the negative charge-pump regulator. The charge-pump controller includes a high-side p-channel MOSFET (P1) and a low-side n-channel MOSFET (N1) to control the power transfer.

The feedback signal (FBGL) is compared with a 0.25V internal reference obtained by partitioning the main 1.25V reference. The result of this comparison is sampled on every clock cycle. If (REF - FBGL) is less than 1.25V - 0.25V or 1V, a DRVN cycle is initiated. In the first half period, the rising edge of the clock turns on P1 and turns off N1, allowing the flying capacitors to charge, while during the second half period, the falling edge of the clock turns on N1 and turns off P1 allowing charge transfer to the output. During both phases, N1 and P1 act as current-limited switches with a current limit of at least 15mA.

Alternatively, if (REF - FBGL) is less than 1V at the clock rising edge, the regulator ignores the clock period and N1 and P1 remain off.

For sequencing of the output voltages at turn-off, a discharge switch is connected from VGOFF to ground. The desired sequence is programmable using the SEQ pin or through I²C. See Table 3 for the stand-alone sequencing options.

Fault Protection on the TFT Section

The ICs have robust fault and overload protection. If any of the source-driver or gate-driver supplies fall below 80% (typ) or above 115% of the programmed regulation voltage for more than 60ms (typ, default), all the outputs turn off and a fault condition is set. If a short condition occurs on any of the source-driver supplies for more than 10µs, all the outputs turn off and a fault condition is set. A short condition is detected when the output voltage falls below 40% of the intended regulation voltage. The output with the fault turns off immediately, while the other outputs follow the turn-off sequence programmed by the SEQ pin or through I²C. The fault condition is cleared when the ENP pin or INA supply is cycled or after the retry timer (2.4s typ, default) times out, if enabled. If needed, the retry time can be adjusted or this function disabled using the serial interface. In the case of a thermal fault, the ICs turn off immediately and remain off until the chip temperature drops by 15°C (typ).

Output Control

The sequencing of the source-driver and gate-driver outputs (AVDD, VGON, and VGOFF) is determined by the setting of the SEQ pin or through I²C. All outputs are brought up with soft-start control to limit the inrush current. Table 3 lists the sequencing options using the SEQ pin.

The outputs are also turned off in sequence, with the boost converter the last block to be disabled. Active pulldowns are provided on all outputs to facilitate a controlled discharge. The pulldowns remain active for 512ms after the boost has been disabled, at which point the ICs enter shutdown mode, if applicable.

Power-Up/Power-Down Sequencing and Timing

The ICs allow for flexible power-up/power-down sequencing and timing of the source-driver and gate-driver power supplies (AVDD, VGON, and VGOFF). Toggling the ENP pin from low to high initiates an adjustable preset power-up sequence. Alternatively, power-up sequencing can be controlled through I²C. Toggling the ENP pin from high to low

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initiates the power-down sequence. The ENP pin has an internal deglitching filter of 10µs (typ). **Note:** A glitch in the ENP signal with a period less than 10µs is ignored by the internal enable circuitry.

Gate-Shading Level Shifter

The gate-shading level shifter is enabled when the soft-start of all regulators is completed and the DEL pin exceeds its enable threshold. A capacitor on the DEL pin can be used to adjust the startup-delay time together with the internal 5µA current source. The delay can be calculated using the following equation:

Delay =
$$\frac{\left(1.25V \times C_{\text{DEL}}\right)}{5\mu\text{A}}$$

When the ICs are disabled, GATES is discharged to GND. After the ICs are enabled, the GATES switches are off and GATES is high impedance until the complete power sequence is finished (without a fault occurring) and DEL exceeds 1.25V. When DEL exceeds 1.25V, the level shifter is activated and its state controlled by the CTL and MODE inputs according to Table 1. An external resistor and capacitor are used to produce the desired waveform where the rise of the output signal is fast, but the fall is an exponential decay controlled by the external values of the resistor and capacitor. In addition, a capacitor on the MODE pin can be used to delay the fall of the GATES output.

Connect MODE to INA when the V_{GGS} delay is not needed. Connect a capacitor from MODE to GND to set the delay according to the following equation:

$$C_{\text{MODE}} = \frac{\left(100\,\mu\text{A} \times t_{\text{DMODE}}\right)}{1.75V}$$

where t_{DMODE} is the desired delay if the level shifter is not used to connect CTL to GND.

Table 1

Table 1. Gate-Shading Operating Modes

		<u> </u>	
CTL	MODE	GATES OUTPUT	C _{MODE} DISCHARGE
Low	High	GATES shorted to DRN using internal device	_
High	High	GATES shorted to SRC using internal device	_
Low	Low	GATES shorted to DRN using internal device	Off
High	Low	GATES shorted to SRC using internal device	On

VCOM Buffer

The VCOM buffer is enabled when AVDD crosses its power-good threshold. The VCOM positive supply is V_{COMP} , which is normally externally connected to the AVDD output, while its negative supply is ground. The output voltage is set by default to half of V_{COMP} through two $1000 k\Omega$ internal resistors. The VCOM buffer can be controlled either by driving the VCINH pin or using the internal DAC that is written to through the serial interface. When driving the VCINH pin, the source impedance or the resistance of the external resistor-divider should be much lower than $500 k\Omega$. In DAC mode, an 8-bit value is written through I^2C , which sets the VCOM output voltage in a nominal range of $\pm 2.5V$ around AVDD/2. Table 2 shows the correspondence between the DAC value written and the VCOM output voltage. The VCOM output can source or sink a current up to a peak of 130 mA. The LCD backplane consists of a distributed series capacitance and resistance, a load that can be easily driven by the buffer. In a short-circuit condition, the power dissipation of the VCOM buffer can lead to complete thermal shutdown of the ICs.

The VCOM buffer should be used with an external 1µF ceramic capacitor connected from its output to GND.

A VCOM buffer fault is detected if the voltage difference between VCINH and the VCOM output pin is greater than 250mV. The VCOM fault detection is filtered internally and a VCOM buffer fault is latched. To clear a fault, write a 0 to the corresponding fault bit. In stand-alone mode, toggle the ENP pin or power down the device and then power it on again.

Table 2. VCOM DAC Values

DAC VALUE	NOMINAL VCOM OUTPUT VOLTAGE WITH V _{AVDD} = 12V
0xFF	8.5V
0xFE	8.5V
0x80	6.02V
0x7F	6V
0x7E	5.98V
0x01	3.52V
0x00	3.5V

FLTB Output

The FLTB output pin is an active-low, open-drain output that can be used to signal various device faults (for operation in stand-alone mode, see the *Stand-Alone Mode* section). When the I²C interface is used, the FLTB output can flag any or all of the following conditions:

- Overtemperature fault
- Overcurrent on AVDD
- Undervoltage on HVINP, VGON, or VGOFF
- Overvoltage on HVINP, VGON, or VGOFF
- VCOM overvoltage or undervoltage

Some of the above conditions can be masked from causing FLTB to go low by using the corresponding mask bit in the Fault Mask 1 (0x08) and Fault Mask 2 (0x09) registers.

Stand-Alone Mode

The ICs can be used either in stand-alone mode (when there is no local microcontroller), or in I²C mode. In stand-alone mode, the SEQ pin sets the sequence according to Table 3.

The ENP pin (active high) is used to turn on or off the complete device. In stand-alone mode, the open-drain FLTB output is high when there is no detected fault. When a fault is detected, the FLTB pin outputs a signal with a duty cycle that indicates what type of fault has been detected. This is summarized in Table 4.

Table 3. Output Sequencing

NOMINAL SEQ PIN VOLTAGE	POW	ER-ON SEQUE	NCING	POWER-OFF SEQUENCING			
NOMINAL SEQ FIN VOLTAGE	1st	2nd	3rd	1st	2nd	3rd	
GND	I ² C CONTROL						
INA/2	AVDD	VGOFF	VGON	VGON	VGOFF	AVDD	
INA	AVDD	VGON	VGOFF	VGOFF	VGON	AVDD	

Table 4

Table 4. FLTB Output Duty Cycle

FLTB DUTY CYCLE	ERROR CONDITION				
Continuously high	No error				
75%	VGON or VGOFF fault				

Table 4. FLTB Output Duty Cycle (continued)

50%	HVINP fault	
25%	AVDD fault	
1.5%	Thermal shutdown	

I2C Serial Interface

The ICs contain an I²C serial interface and act as slave devices. The basic unit of data transfer is 8 bits. To select I²C mode, connect the SEQ pin to GND. The state of the SEQ pin is sampled when the INA voltage exceeds approximately 2V and the status is latched.

Control of the power-up sequence through I^2C can be performed in two ways, manual or automatic. In manual mode, the I^2C host enables the outputs individually using the bits in the Regulator Control register (0x02). If a fault is detected in manual mode, the faulty output is disabled after the corresponding deglitch time and no other action is performed. Retry is disabled in manual mode.

The bits in Fault registers 0x0A and 0x0B can be cleared by writing a 0 to the corresponding position in the register. If the values of the other bits are retained, a 1 should be written to them. (e.g., if the vgon_ov bit is cleared in register 0x0A, 0x77 should be written to the register). In this manner, only bit 3 is cleared, and the other bits are left unchanged.

In automatic mode, the sequence is preset using the autoseq_row1—autoseq_row3 and textd_dly1, textd_dly2 bits, and executed using the autoseq_ctrl bit. See the *Automatic Sequencing Mode* section for further details.

I2C Protocol

The I²C address is chosen by connecting the ADD pin to either GND or INA (see Table 5). A master device communicates with the IC by transmitting the correct Slave ID followed by the register address and data word. Each transmit sequence is framed by a START (S) or Repeated START (Sr) condition and a STOP (P) condition. Each word transmitted over the bus is 8 bits long and is always followed by an acknowledge clock pulse.

The SDA line operates as both an input and an open-drain output. A pullup resistor greater than 500Ω is required on the SDA bus, or the resistor has to be selected as a function of bus capacitance, such that the rise time on the bus is not greater than 120ns per the I^2 C bus specification. The SCL line operates as an input only. A pullup resistor greater than 500Ω is required on SCL if there are multiple masters on the bus, or if the master in a single-master system has an open-drain SCL output. In general, for the SCL line resistor selection, the same recommendations as the SDA line apply. Series resistors in line with SDA and SCL are optional. The SCL and SDA inputs suppress noise spikes to ensure proper device operation even on a noisy bus.

Table 5. I²C Slave Addresses

ADD PIN CONNECTION	DEVICE ADDRESS							WRITE	READ	
ADD FIN CONNECTION	A6	A5	A4	А3	A2	A 1	A0	ADDRESS	ADDRESS	
GND	0	1	0	0	0	0	0	0x40	0x41	
INA	0	1	0	1	0	0	0	0x50	0x51	

Individual Output Control Through I2C

Using the bits in the Regulator Control register (0x02), all outputs can be controlled individually by the local host microcontroller. When using this mode of operation, a fault on any output is signaled by the FLTB output pin (if not masked) and the fault bits. The output with the fault remains active until the microcontroller intervenes.

When using the individual control bits, the boost converter must always be enabled first and disabled last in the sequence.

Autosequencing Mode

In autosequencing mode, a complete sequence is configured using the autoseq_row1-3[2:0] and textd_dly1-2 bits and

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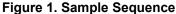
then executed by setting the autoseg ctrl bit.

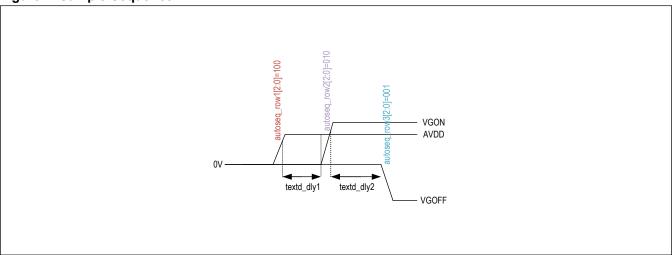
To use autosequencing, set the en_autoseq bit in the Configurations register (0x01) to 1 and then configure the desired sequence using the autoseq_row1-autoseq_row3 bits in the Auto Sequencing ctrl1 (0x04) and Auto Sequencing ctrl2 (0x05) registers. The 3 bits of autoseq_row1 correspond to the AVDD output and each bit represents one of three time slots. To enable AVDD during the first time slot, set autoseq_row1 to 100. To enable AVDD during the second time slot, set autoseq_row1 to 010, etc. In an analogous fashion, autoseq_row2 sets the VGON time slot and autoseq_row3 sets the VGOFF time slot.

The delays between each of the time slots are configured using the textd dly1 and textd dly2 settings.

When the complete configuration is set, the sequence is executed automatically by setting autoseq_ctrl in the Regulator Control register (0x02) to 1. The corresponding power-off sequence can be performed by setting autoseq_ctrl to 0. If a fault occurs in automatic mode, the faulty output is turned off and the other outputs are turned off in the set order. If retry is enabled, a retry is attempted after the appropriate delay.

Note: If the manual control bits have been used to enable one or more of the outputs, automatic sequencing behaves differently: it starts immediately when the en autoseq bit is set.





Register Map

Register Map

ADDRESS	NAME	MSB							LSB
bank 0		1		1		1		11	
0x00	Device Id[7:0]		rev_i	d[3:0]			dev_i	d[3:0]	
0x01	Configurations[7:0]	fault_latc h_dis	en_autos eq	tretry	/[1:0]	tfault[1:0]		dis_ss	swfrq
0x02	Regulator control[7:0]	_	autoseq_ ctrl	dis_vco m	dis_gs	en_vgoff	en_vgon	en_avdd	en_bst
0x03	Regulator power status[7:0]	_	_	vcom_on	gs_on	vgoff_on	vgon_on	avdd_on	bst_on
0x04	Auto sequencing ctrl1[7:0]	_	_	aut	oseq_row2[2:0] aut		toseq_row1[2:0]	
0x05	Auto sequencing ctrl2[7:0]	_	textd_d	ly2[1:0]	textd_d	lly1[1:0] autoseq_row3[2:0]		2:0]	
0x06	VCOM voltage[7:0]				vcom_c	dac[7:0]			
0x07	UNUSED - do not write to this register[7:0]	_	_	_	_	_	_	_	-
0x08	Fault mask 1[7:0]	_	vgoff_uv _mask	vgoff_ov _mask	vgon_uv _mask	vgon_ov _mask	avdd_ovl d_mask	hvinp_uv _mask	hvinp_ov _mask
0x09	Fault mask 2[7:0]	_	_	_ vcom_uv _mask		vcom_ov _mask	_	_	_
0x0A	Fault register 1[7:0]	_	vgoff_uv	vgoff_ov	vgon_uv	vgon_ov	avdd_ovl d	hvinp_uv	hvinp_ov
0x0B	Fault register 2[7:0]	_	_	_	vcom_uv	vcom_ov	_	th_shdn	hw_rst

Register Details

Device Id (0x00)

Register to identify the device type and the revision number

BIT	7	6	5	4	3	2	1	0		
Field		rev_i	d[3:0]		dev_id[3:0]					
Reset		0:	x0		0x9					
Access Type		Read	l Only		Read Only					

BITFIELD	BITS	DESCRIPTION	
rev_id	7:4	Revision ID. 0 = revision 1, etc.	
dev_id	3:0	Device ID. Reads 0x9.	

Configurations (0x01)

Miscellaneous configurations needed for part operations

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BIT	7	6	5	4	3	2	1	0
Field	fault_latch_ dis	en_autoseq	tretry[1:0]		tfault[1:0]		dis_ss	swfrq
Reset	0x0	0x0	0x2		0x1		0x0	0x0
Access Type	Write, Read	Write, Read	Write, Read		Write, Read		Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION	DECODE		
fault_latch_di s	7	Fault register control. When set to 0, the fault register bits are latched.	0x0: Fault register bits are latched fault flags 0x1: Fault register bits are fault status bits (no latching)		
en_autoseq	6	When set to 1, this bit enables the automatic sequencing feature.	0x0: Automatic sequencing is disabled 0x1: Automatic sequencing is enabled		
tretry	5:4	If retry is enabled (set to any value other than 0x0), then this is the time that elapses before a new power-on is attempted after turn-off due to a regulator fault.	0x0: Retry is disabled 0x1: Retry to power on regulator after 0.95s 0x2: Retry to power on regulator after 1.9s 0x3: Retry to power on regulator after 3.8s		
tfault	3:2	Fault-deglitch duration. This is the time that a regulator fault must be continuously present before the fault is considered valid.	0x0: 30ms 0x1: 60ms 0x2: 120ms 0x3: 250ms		
dis_ss	1	Boost spread-spectrum-disable control bit.	0x0: Boost spread spectrum enabled 0x1: Boost spread spectrum disabled		
swfrq	0	Boost converter switching-frequency selection.	0x0: 2.2MHz boost switching frequency 0x1: 440kHz boost switching frequency		

Regulator control (0x02)

Direct control of regulators enable. This register can be used on I2C variant when "en_autoseq = 0" to control the manual sequencing of regulators, i.e. regulators sequencing is completely controlled by host software. Note that some controls are implemented in this registers. As an example the enable of any regulator is not allowed unless "en_bst" has been enabled and ready (bst_on = 1).

BIT	7	6	5	4	3	2	1	0
Field	_	autoseq_ctrl	dis_vcom	dis_gs	en_vgoff	en_vgon	en_avdd	en_bst
Reset	_	0x0	0x0	0x0	0x0	0x0	0x0	0x0
Access Type	-	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION	DECODE
autoseq_ctrl	6	Controls the automatic sequencer. If the automatic sequencer is enabled, setting this bit to 1 starts the power-on sequence as programmed. Deasserting this bit to 0 starts the power-down sequence. Note that the sequence programming cannot be altered while the sequence is ongoing. Once the current sequence is completed, sequence programming is again enabled. If the en_autoseq bit is set to 0, this bit has no effect.	0x0: If regulators are off, keep them as they are. If regulators are on, start the power off sequence and keep them off 0x1: If regulators are off start the power on sequence and keep them on. Else keep them as they are.

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BITFIELD	BITS	DESCRIPTION	DECODE		
dis_vcom	5	VCOM buffer disable. By default, the VCOM buffer is enabled when the AVDD crosses its power-good threshold.	0x0: VCOM buffer is enabled 0x1: VCOM buffer has been disabled		
dis_gs	4	Gate-shading disable. By default, the gate- shading block is enabled when soft-start for all regulators is completed and when the DEL pin exceeds its enable threshold.	0x0: Gate shading is enabled 0x1: Gate shading has been disabled		
en_vgoff	3	Negative charge-pump enable.	0x0: Negative charge pump is disabled 0x1: Negative charge pump has been enabled		
en_vgon	2	Positive charge-pump enable.	0x0: Positive charge pump is disabled 0x1: Positive charge pump has been enabled		
en_avdd	1	Control bit for the switch between HVINP and AVDD. Note that any attempt to set this bit to 1 fails if the field "bst_ok" is 0.	0x0: Switch beween HVINP and AVDD is open 0x1: Switch beween HVINP and AVDD is closed		
en_bst	0	Boost converter enable.	0x0: Buck is disabled 0x1: Buck is enabled		

Regulator power status (0x03)

Status of the regulators. Each bit set to 1 means that related regulator is powered on (i.e. it has been enabled, the transient has completed and it's active ready)

BIT	7	6	5	4	3	2	1	0
Field	1	ı	vcom_on	gs_on	vgoff_on	vgon_on	avdd_on	bst_on
Reset	-	-	0x0	0x0	0x0	0x0	0x0	0x0
Access Type	1	-	Read Only					

BITFIELD	BITS	DESCRIPTION	DECODE		
vcom_on	5	This bit shows the status of the VCOM buffer.	0x0: The VCOM buffer is off 0x1: The VCOM buffer is on		
gs_on	4	This bit shows the status of the gate-shading block.	0x0: The gate shading is off 0x1: The gate shading is on		
vgoff_on	3	This bit shows the status of the negative charge pump.	0x0: The charge pump is off 0x1: The charge pump is on		
vgon_on	2	This bit shows the status of the positive charge pump.	0x0: The charge pump is off 0x1: The charge pump is on		
avdd_on	1	This bit shows the status of the switch between HVINP and AVDD.	0x0: The switch is open 0x1: The switch is closed		
bst_on	0	When this bit is set to 1, the boost converter has been activated and its output voltage is in range.	0x0: Boost has not been activated 0x1: Boost has been activated and power on transient completed		

Auto sequencing ctrl1 (0x04)

Programming for the control of the automatic sequncing

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BIT	7	6	5	4	3	2	1	0
Field	_	=	aı	utoseq_row2[2	0]	autoseq_row1[2:0]		
Reset	_	_		0x0			0x0	
Access Type	_	_	Write, Read				Write, Read	

BITFIELD	BITS	DESCRIPTION
autoseq_row2	5:3	Autosequencing matrix row 2, corresponding to VGON. A 1 in this bit corresponds to start the regulator in slot 1, 2, or 3 depending on the position of the 1. If more than a 1 is present in the field, only the first one is considered valid.
autoseq_row1	2:0	Autosequencing matrix row 1, corresponding to AVDD. A 1 in this bit corresponds to start the regulator in slot 1, 2, or 3 depending on the position of the 1. If more than a 1 is present in the field, only the first one is considered valid.

Auto sequencing ctrl2 (0x05)

Programming for the control of the automatic sequncing

BIT	7	6	5	4	3	2	1	0
Field	_	textd_dly2[1:0] textd_dly1[1:0]		ly1[1:0]	autoseq_row3[2:0]			
Reset	-	0:	x0	0x0		0x0		
Access Type	_	Write,	, Read	Write, Read Write, Read		Write, Read		

BITFIELD	BITS	DESCRIPTION	DECODE
textd_dly2	6:5	Delay extension as a percentage of the time that elapses between the power-on command for regulators in slot 2 and the assertion of the feedback signal that notifies they completed ramp up. If we name Tok such time the delay between slot 2 and slot 3 will be Tok x (1 + textd_dly2).	0x0: No delay after power OK of preceeding regulators 0x1: Additional 10% delay after power OK of preceeding regulators 0x2: Additional 20% delay after power OK of preceeding regulators 0x3: Additional 30% delay after power OK of preceeding regulators
textd_dly1	4:3	Delay extension as a percentage of the time that elapses between the power-on command for regulators in slot 1 and the assertion of the feedback signal that notifies they completed ramp up. If we name Tok such time the delay between slot 1 and slot 2 will be Tok x (1 + textd_dly1).	0x0: No delay after power OK of preceeding regulators 0x1: Additional 10% delay after power OK of preceeding regulators 0x2: Additional 20% delay after power OK of preceeding regulators 0x3: Additional 30% delay after power OK of preceeding regulators
autoseq_row 3	2:0	Autosequencing matrix row 3, corresponding to VGOFF. A 1 in this bit corresponds to start the regulator in slot 1, 2, or 3 depending on the position of the 1. If more than a 1 is present in the field, only the first one is considered valid.	

VCOM voltage (0x06)

This byte controls the setting of the DAC controlling the VCOM output voltage

Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

BIT	7	6	5	4	3	2	1	0
Field	vcom_dac[7:0]							
Reset	0x7F							
Access Type				Write,	Read			

BITFIELD	BITS	DESCRIPTION
vcom_dac	7:0	This byte controls the DAC that sets the VCOM output voltage. The output step is 20mV/LSB. The mid-point is 0x7F = AVDD/2.

Fault mask 1 (0x08)

Fault mask register. Each bit in this register is able to mask the fault of the related bit. A 1 in a position enables the contribution of the fault flag to the FLTB assertion.

BIT	7	6	5	4	3	2	1	0
Field	_	vgoff_uv_m ask	vgoff_ov_m ask	vgon_uv_m ask	vgon_ov_m ask	avdd_ovld_ mask	hvinp_uv_m ask	hvinp_ov_m ask
Reset	_	0x0	0x0	0x0	0x0	0x0	0x0	0x0
Access Type	_	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read	Write, Read

BITFIELD	BITS	DESCRIPTION
vgoff_uv_mask	6	Mask for VGOFF undervoltage fault. If this bit is set to 1, an undervoltage fault on VGOFF does not cause FLTB to go low.
vgoff_ov_mask	5	Mask for VGOFF overvoltage fault. If this bit is set to 1, an overvoltage fault on VGOFF does not cause FLTB to go low.
vgon_uv_mask	4	Mask for VGON undervoltage fault. If this bit is set to 1, an undervoltage fault on VGON does not cause FLTB to go low.
vgon_ov_mask	3	Mask for VGON overvoltage fault. If this bit is set to 1, an overvoltage fault on VGON does not cause FLTB to go low.
avdd_ovld_mask	2	Mask for AVDD overcurrent fault. If this bit is set to 1, an overcurrent fault on AVDD does not cause FLTB to go low.
hvinp_uv_mask	1	Mask for HVINP underervoltage fault. If this bit is set to 1, an undervoltage fault on HVINP does not cause FLTB to go low.
hvinp_ov_mask	0	Mask for HVINP overvoltage fault. If this bit is set to 1, an overvoltage fault on HVINP does not cause FLTB to go low.

Fault mask 2 (0x09)

Fault mask register. Each bit in this register is able to mask the fault of the related bit. A 1 in a position enables the contribution of the fault flag to the FLTB assertion.

CONTINUATION OF								
BIT	7	6	5	4	3	2	1	0
Field	_	_	_	vcom_uv_m ask	vcom_ov_m ask	_	_	_
Reset	_	-	-	0x0	0x0	-	_	_
Access Type	_	_	_	Write, Read	Write, Read	_	_	_

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BITFIELD	BITS	DESCRIPTION
vcom_uv_mask	4	Mask for VCOM undervoltage fault. If this bit is set to 1, an undervoltage fault on VCOM does not cause FLTB to go low.
vcom_ov_mask	3	Mask for VCOM overvoltage fault. If this bit is set to 1, an overvoltage fault on VCOM does not cause FLTB to go low.

Fault register 1 (0x0A)

Fault register 1. Each bit of this register can be a status bit (reflecting current status of the fault) or a flag bit (latched version of a status bit).

BIT	7	6	5	4	3	2	1	0
Field	_	vgoff_uv	vgoff_ov	vgon_uv	vgon_ov	avdd_ovld	hvinp_uv	hvinp_ov
Reset	_	0x0						
Access Type	_	Write 0 to Clear, Read						

BITFIELD	BITS	DESCRIPTION	DECODE
vgoff_uv	6	VGOFF undervoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present else this bit is 0.
vgoff_ov	5	VGOFF overvoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.
vgon_uv	4	VGON undervoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.
vgon_ov	3	VGON overvoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.
avdd_ovld	2	AVDD overcurrent fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.
hvinp_uv	1	HVINP undervoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.

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BITFIELD	BITS	DESCRIPTION	DECODE
hvinp_ov	0	HVINP overvoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.

Fault register 2 (0x0B)

Fault register 2. Each bit of this register is a flag bit (latched fault).

			o aa.g (
BIT	7	6	5	4	3	2	1	0
Field	_	_	-	vcom_uv	vcom_ov	_	th_shdn	hw_rst
Reset	-	-	-	0x0	0x0	-	0x0	0x1
Access Type	_	_	_	Write 0 to Clear, Read	Write 0 to Clear, Read	_	Write 0 to Clear, Read	Read Only

BITFIELD	BITS	DESCRIPTION	DECODE	
vcom_uv	4	VCOM buffer undervoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.	
vcom_ov	3	VCOM buffer overvoltage fault. Depending on programing of "fault_latch_dis," this is a status bit or a clear-on-read flag bit.	0x0: No fault is present or has happened 0x1: If "fault_latch_dis" = 0 then a fault has happened or is still present. In this case the bit is CoR, but reasserts if fault is still present. If "fault_latch_dis" = 1 then a fault is currently present, else this bit is 0.	
th_shdn	1	Thermal-shutdown event was detected. If the event is still on, the flag reasserts upon CoR.	0x0: no thermal shutdown since last read 0x1: Device is in thermal shutdown	
hw_rst	0	Hardware reset event was detected	0x0: no POR since last read 0x1: this is the first read from the device after a POR	

Applications Information

Boost Converter

Inductor Selection

The value of the boost inductor is determined as follows:

$$L = \frac{\left(V_{\text{INA}} \times D\right)}{\left(\text{LIR} \times I_{\text{INA}} \times f_{\text{SW}}\right)}$$

where V_{INA} is the boost input voltage, D is the duty cycle, LIR is the current ripple factor in the inductor (choose a value between 0.5 and 1), I_{INA} is the boost converter input current, and f_{SW} is either 2.2MHz or 440kHz.

Calculate the duty-cycle using:

$$D = \frac{\left(1 - \eta \times V_{\text{INA}}\right)}{V_{\text{OUT}}}$$

where η is the converter efficiency (assume 0.85) and V_{OUT} is the boost output voltage.

I_{INA}, the average input current, can be estimated as follows:

$$I_{\mathsf{INA}} = \frac{\left(V_{\mathsf{OUT}} \times I_{\mathsf{OUT}}\right)}{\left(\eta \times V_{\mathsf{INA}}\right)}$$

where IOUT is the boost output current.

Capacitor Selection

The input and output filter capacitors should be a low-ESR type (e.g., tantalum, ceramic, or low-ESR electrolytic) and should have RMS current ratings greater than:

$$I_{RMS} = \frac{\left(LIR \times I_{INA}\right)}{\sqrt{12}}$$

for the input capacitor, and:

$$I_{\text{RMS}} = I_{\text{OUT}} \times \sqrt{\frac{D + \frac{\text{LIR}^2}{12}}{(1 - D)}}$$

for the output capacitor. The output voltage contains a ripple component whose peak-to-peak value depends on the value of the ESR and capacitance of the output capacitor and is approximately the sum of two contributions:

$$\Delta V_{RIPPLE} = \Delta V_{ESR} + \Delta V_{CAP}$$

where:

$$\Delta V_{ESR} = I_{INA} \times \left(1 + \frac{LIR}{2}\right) \times R_{ESR}$$

and

$$\Delta V_{CAP} = \frac{\left(I_{OUT} \times D\right)}{\left(C_{OUT} \times f_{SW}\right)}$$

where R_{ESR} is the ESR of the chosen output capacitor.

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Output-Voltage Selection

The output voltage of the boost converter can be adjusted using a resistive voltage-divider formed by R_{TOP} and R_{BOTTOM} . Connect R_{TOP} between HVINP and FBP, and connect R_{BOTTOM} between FBP and GND. Select R_{BOTTOM} in the $10k\Omega$ to $50k\Omega$ range. Calculate R_{TOP} with the following equation:

$$R_{\text{TOP}} = R_{\text{BOTTOM}} \times \left(\left(\frac{V_{\text{OUT}}}{1.25} \right) - 1 \right)$$

Place the resistors close to the device and connect R_{BOTTOM} to the analog ground plane.

Boost Converter Operation at low INA and high Output Power

At high boost output power and low input voltages, the input current becomes high and and the boost converter's efficiency is lower. Under these conditions, it may be preferable to use the 440kHz low-frequency setting. A further boost in efficiency at low input voltages can be obtained by adding a Schottky diode from LXP to HVINP. See all the relevant curve in the *Typical Operating Characteristics* section

Charge-Pump Regulators

Selecting the Number of Charge-Pump Stages

For highest efficiency, always choose the lowest number of charge-pump stages that meet the output voltage requirement. The number of positive charge-pump stages is given by:

$$nPOS = \frac{VGON + V_{DROPOUT} - V_{AVDD}}{V_{SUP} - 2 \times V_D}$$

where nPOS is the number of positive charge-pump stages, VGON is the output of the positive charge-pump regulator, V_{SUP} is the supply voltage of the charge-pump regulators (HVINP), V_{D} is the forward voltage drop of the charge-pump diodes, and $V_{DROPOUT}$ is the dropout margin for the regulator. Use $V_{DROPOUT}$ = 600mV.

The number of negative charge-pump stages is given by:

$$nNEG = \frac{-VGOFF + V_{DROPOUT}}{V_{SUP} - 2 \times V_D}$$

where nNEG is the number of negative charge-pump stages and VGOFF is the output of the negative charge-pump regulator.

Flying Capacitors

Increasing the flying capacitor (connected to DRVN and DRVP) value lowers the effective source impedance and increases the output current capability. Increasing the capacitance indefinitely, however, has a negligible effect on output-current capability because the internal switch resistance and the diode impedance place a lower limit on the source impedance. A 0.1µF ceramic capacitor works well in most applications. The flying capacitor's voltage rating must exceed the following:

$$VCX > n \times V_{HVINP}$$

where n is the stage number in which the flying capacitor appears.

Charge-Pump Output Capacitor

Increasing the output capacitance or decreasing the ESR reduces the output ripple voltage and the peak-to-peak transient voltage. With ceramic capacitors, the output-voltage ripple is dominated by the capacitance value. Use the following equation to approximate the required capacitor value:

$$C_{\text{OUT_CP}} > \frac{I_{\text{LOAD_CP}}}{2xf_{\text{SW}} \times V_{\text{RIPPLE_CP}}}$$

where C_{OUT_CP} is the output capacitor of the charge pump, I_{LOAD_CP} is the load current of the charge pump, V_{RIPPLE_CP} is the desired peak-to-peak value of the output ripple, and f_{SW} is the switching frequency, which is 440kHz.

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Power Dissipation

The total internal power dissipation comprises five terms:

- 1. Boost converter power dissipation
- 2. Positive charge-pump dissipation
- 3. Negative charge-pump dissipation
- 4. Gate-shading power dissipation
- 5. VCOM buffer power dissipation

Items 2-4 are negligible, while the other terms can be estimated using:

$$P_{\text{BOOST}} = I^2_{\text{INA}} \times R_L \times D + I^2_{\text{INA}} \times R_H \times (1 - D) + 0.5 \times I_{\text{INA}} \times V_{\text{HVINP}} \times t_{\text{RF}} \times f_{\text{SW}}$$

where R_L is the low-side LXP switch resistance, R_H is the high-side LX switch resistance, and t_{RF} is the LXP rise/fall time that can be approximated by 5ns:

$$P_{\text{VCOM}} = (V_{\text{AVDD}} - V_{\text{VCOM}}) * I_{\text{VCOM}}$$

where I_{VCOM} is the RMS VCOM buffer output current.

PCB Layout Example

Figure 2 shows an example for the layout of the power components around the MAX20067/MAX20067B. This layout minimizes the area of the LXP node and the area of the switching current loop. Follow these guidelines for the rest of the layout:

- 1. Separate power and analog grounds on the board and connect them together at a single point.
- 2. Connect all feedback resistor-dividers to the analog or "quiet" ground, along with the REF and INA capacitors. Feedback resistors should be placed close to their associated pins to avoid noise pickup.
- 3. Place decoupling capacitors as close as possible to their respective pins.
- 4. Keep high-current paths as short and wide as possible.
- 5. Route high-speed switching nodes (i.e., LXP, DRVN, and DRVP) away from sensitive analog nodes (i.e., FBP, FBGH, FBGL, and REF).

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Layout Example

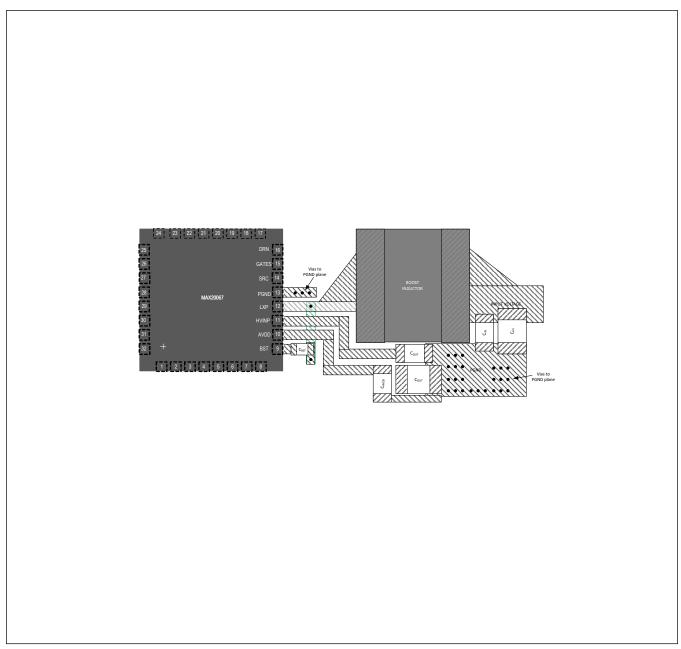


Figure 1. Layout Example

Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE	PKG CODE
MAX20067GTJ/V+	-40°C to +105°C	32 TQFN	T3255+4C
MAX20067BGTJ/V+	-40°C to +105°C	32 TQFN	T3255+4C

[/]V denotes an automotive qualified part.

⁺Denotes a lead(Pb)-free/RoHS-compliant package.

Automotive 3-Channel Display Bias IC with VCOM Buffer, Level Shifter, and I²C Interface

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	7/17	Initial release	
1	9/20	Added MAX20067B variant, adjusted VGON, SRC and DRN absolute maximum ratings and operating voltage ranges.	1, 3, 4, 5, 6, 16
2	1/21	Changed maximum value of VGOFF Output Voltage Range to -4V, adjusted VGON, SRC and DRN absolute maximum ratings and operating voltage ranges.	1, 3, 4, 5, 6, 16

For pricing, delivery, and ordering information, please visit Maxim Integrated's online storefront at https://www.maximintegrated.com/en/storefront/storefront.html.

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